

Interference Searched	Application/Control No.	Applicant(s)/Patent Under Reexamination
	10537867	HAIMER, FRANZ
	Examiner Fulton, Christopher W	Art Unit 2859

Class	SubClass	Date	Examiner
PG-Pub	33559,556,558,561,520,644/	6/25/06	CWF

U.S. Patent and Trademark Office	Part of Paper No.:	20060625
----------------------------------	--------------------	----------